

Supporting Information
for
Rational Design of Ternary-phase Polymer Solar Cells by Controlling Polymer Phase Separation

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1. Absorption Spectroscopy

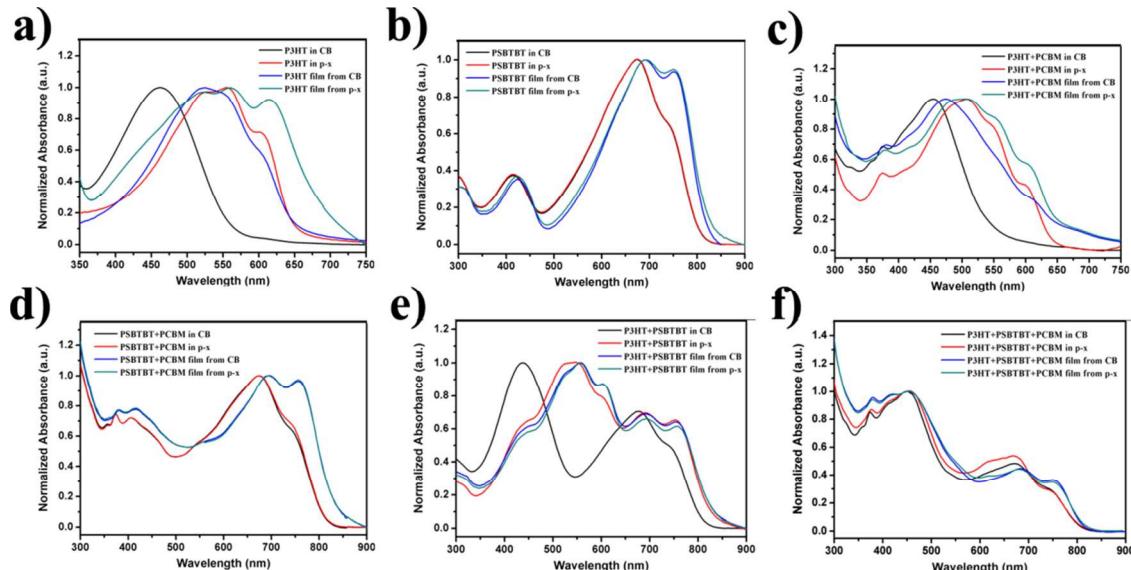


Figure S1. UV-vis absorption spectroscopy of the solutions in CB and p-x and films fabricated from them: a) P3HT; b) PSBTBT; c) P3HT+PC₇₁BM (1:1); d) PSBTBT+PC₇₁BM (1:1); e) P3HT+PSBTBT (1:1); f) P3HT+PSBTBT+PC₇₁BM (1:1:2).

2. AFM Characterization

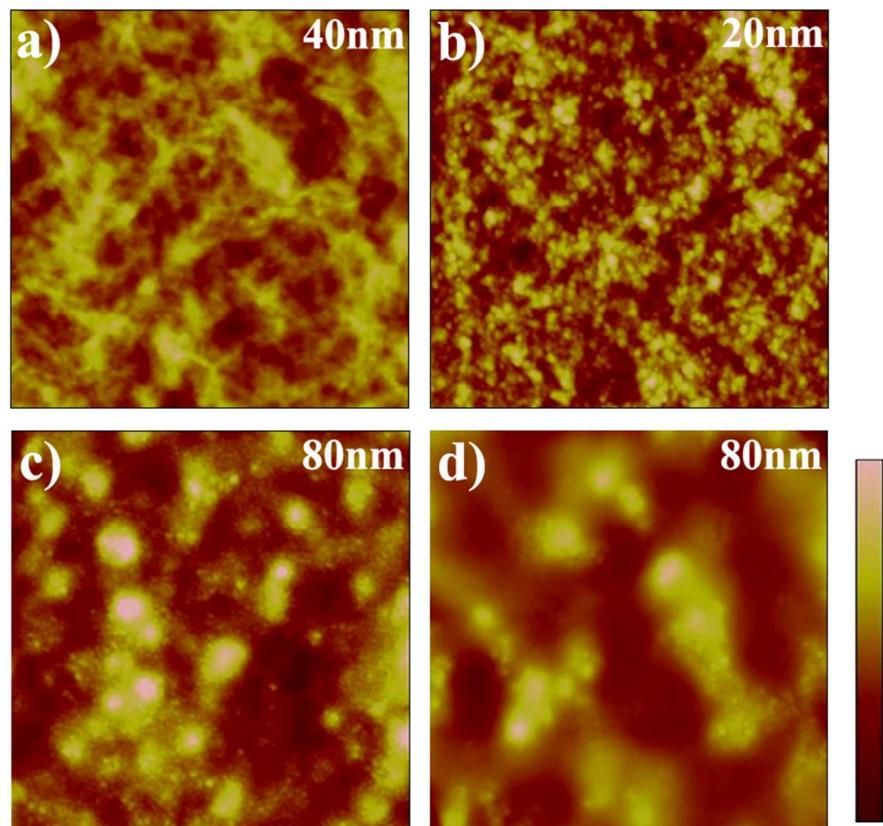


Figure S2. Tapping-mode AFM ($2 \mu\text{m} \times 2 \mu\text{m}$) phase images: a) Pure P3HT film prepared from CB; b) Pure PSBTBT film prepared from p-x; c) Ternary-phase blend film prepared from CB (1:1:2) ; d) Ternary-phase blend film prepared from p-x (1:1:2).

3. XRD Characterization

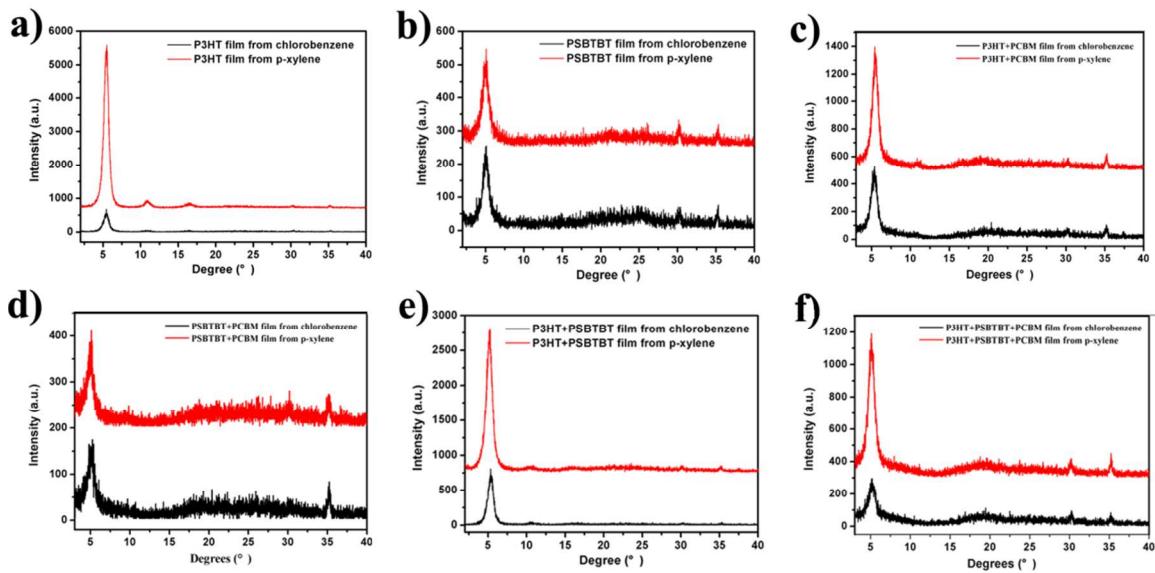


Figure S3. XRD patterns of films prepared from CB and p-x: a) P3HT; b) PSBTBT; c) P3HT+PC₇₁BM (1:1); d) PSBTBT+PC₇₁BM (1:1); e) P3HT+PSBTBT (1:1); f) P3HT+PSBTBT+PC₇₁BM (1:1:2).

4. AFM image corresponding to KPFM measurement

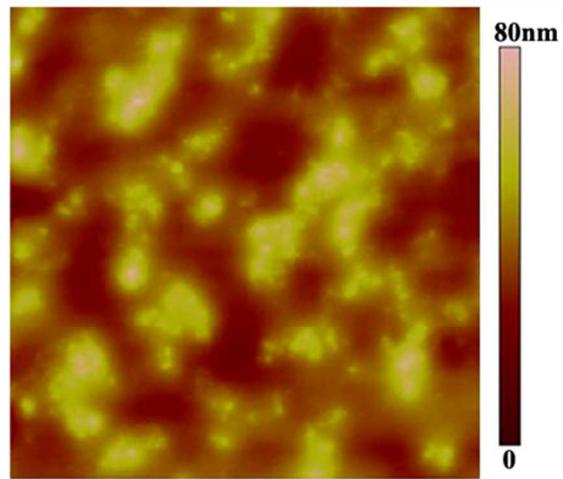


Figure S4. AFM height images ($2\mu\text{m} \times 2\mu\text{m}$) of ternary-phase prepared from p-x (1:1:2).

5. KPFM images under illumination

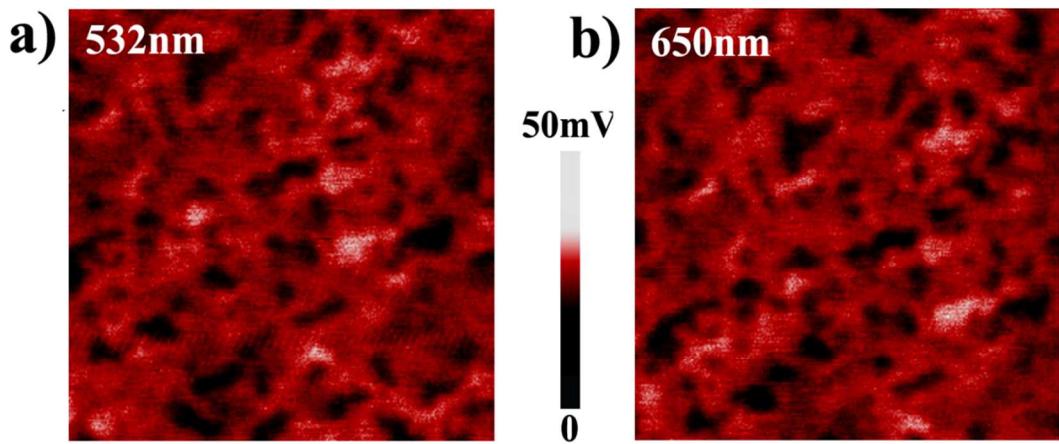


Figure S5. KPFM images ($2 \mu\text{m} \times 2 \mu\text{m}$) of the ternary-phase sample prepared from p-x: a) surface potential image under illumination at 532 nm; b) surface potential image under illumination at 650 nm.

6. Device optimization

Table S1. Performance of P3HT/PC₇₁BM PSCs fabricated from p-x.

Temperature /Anealing time	V _{oc} (V)	J _{sc} (mA/cm ²)	FF (%)	PCE (%)
110°C/15min	0.63	5.1	51	1.9
110°C/30min	0.64	5.2	60	2.3
110°C/60min	0.63	5.0	54	2.0
150°C/15min	0.63	5.8	60	2.6
150°C/30min	0.64	5.7	62	2.6
150°C/60min	0.63	5.4	59	2.4
190°C/15min	0.66	4.8	57	2.1
190°C/30min	0.65	4.6	56	2.0
190°C/60min	0.67	4.3	56	1.9

Table S2. Performance of PSBTBT/PC₇₁BM PSCs fabricated from p-x.

Temperature /Anealing time	V _{oc} (V)	J _{sc} (mA/cm ²)	FF (%)	PCE (%)
110°C/15min	0.65	2.8	31	0.69
110°C/30min	0.65	3.3	32	0.82
110°C/60min	0.66	3.5	31	0.86
150°C/15min	0.63	3.9	32	0.93
150°C/30min	0.66	4.1	34	1.1
150°C/60min	0.65	3.7	34	0.96
190°C/15min	0.65	3.8	32	0.94
190°C/30min	0.66	3.9	32	0.99
190°C/60min	0.65	3.6	32	0.89

Table S3. Performance of ternary-phase PSCs fabricated from p-x.

Temperature /Anealing time	V_{oc} (V)	J_{sc} (mA/cm ²)	FF (%)	PCE (%)
110°C/15min	0.66	4.0	40	1.2
110°C/30min	0.65	4.9	41	1.6
110°C/60min	0.65	6.2	41	1.9
150°C/15min	0.65	6.0	41	1.8
150°C/30min	0.65	7.2	43	2.4
150°C/60min	0.65	3.6	29	0.79
190°C/15min	0.67	3.3	31	0.82
190°C/30min	0.65	2.0	29	0.46
190°C/60min	0.59	1.2	28	0.24